


<b>Search Notes</b>  	<b>Application/Control No.</b>  10620376	<b>Applicant(s)/Patent Under Reexamination</b>  HAYASHI ET AL.
	<b>Examiner</b>  Hodge, Robert	<b>Art Unit</b>  1795

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted Jonathan Crepeau Re Previous Grounds of Rejection and New Grounds of Rejection and Motivation	10/24/07	RWH
See attached East Search History	10/24/07	RWH
Updated Previous East Search History - See attached East Search History	5/14/08	RWH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner